

Notice of References Cited	Application/Control No. 10/757,073		Applicant(s)/Patent Under Reexamination YEH ET AL.	
	Examiner Tan T. Nguyen		Art Unit 2827	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,526,307	06-1996	Yiu et al.	365/185.01
*	B	US-5,576,995	11-1996	Sato et al.	365/185.27
*	C	US-5,953,251	09-1999	Caravella et al.	365/185.18
*	D	US-5,953,255	09-1999	Lee, Peter W.	365/185.29
*	E	US-6,331,953	12-2001	Wang et al.	365/185.29
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	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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